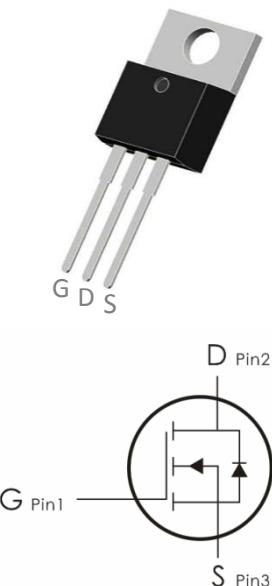


Description:

This N-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=150V, I_D=100A, R_{DS(on)}<15m\Omega @V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra $R_{DS(on)}$.
- 5) Excellent package for good heat dissipation.



Absolute Maximum Ratings: ($T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	150	V
V_{GS}	Gate-Source Voltage	± 25	V
I_D	Continuous Drain Current-	100	A
	Continuous Drain Current- $T_C=100^\circ C$	65	
	Pulsed Drain Current	300	
E_{AS}	Single Pulse Avalanche Energy	272	mJ
P_D	Power Dissipation	428	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55-+150	$^\circ C$

Thermal Characteristics:

Symbol	Parameter	Max	Units
R_{eJC}	Thermal Resistance,Junction to Case ²	0.29	$^\circ C/W$
R_{eJA}	Thermal Resistance,Junction to Ambient	65	

Package Marking and Ordering Information:

Part NO.	Marking	Package
PI015NG	I015N	TO-220

Electrical Characteristics: ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_D=250 \mu\text{A}$	150	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=150\text{V}, T_j=25^\circ\text{C}$	---	0.05	1	μA
		$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=150\text{V}, T_j=150^\circ\text{C}$	---	---	20	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{A}$	---	10	100	nA
On Characteristics						
$V_{\text{GS(th)}}$	GATE-Source Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_D=250 \mu\text{A}$	3	4	5	V
$R_{\text{DS(ON)}}$	Drain-Source On Resistance	$V_{\text{GS}}=10\text{V}, I_D=50\text{A}$	---	10	15	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_D=\text{A}$	---	22	27	
G_{FS}	Forward Transconductance	$V_{\text{DS}}=25\text{V}, I_D=30\text{A}$	---	101	---	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=75\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	---	3593	---	pF
C_{oss}	Output Capacitance		---	331	---	
C_{rss}	Reverse Transfer Capacitance		---	92	---	
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}}=30\text{V}, I_D=2\text{A}, R_{\text{GEN}}=2.5 \Omega, V_{\text{GS}}=10\text{V}$	---	18	---	ns
t_r	Rise Time		---	93	---	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		---	34	---	ns
t_f	Fall Time		---	70	---	ns
R_g	Gate resistance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, f=1\text{MHz}$	---	1.7	---	Ω
Q_g	Total Gate Charge	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=30\text{V}, I_D=30\text{A}$	---	69	---	nC
Q_{gs}	Gate-Source Charge		---	24	---	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	26	---	nC

Drain-Source Diode Characteristics

V_{SD}	Source-Drain Diode Forward Voltage	$V_{GS}=0V, I_S=50A$	---	0.9	1.3	V
T_{rr}	Reverse Recovery Time	$I_F=50A, dI/dt=100A/\mu s$	---	70	---	NS
Q_{rr}	Reverse Recovery Charge	S	---	233	---	NC

Typical Characteristics: ($T_c=25^\circ C$ unless otherwise noted)

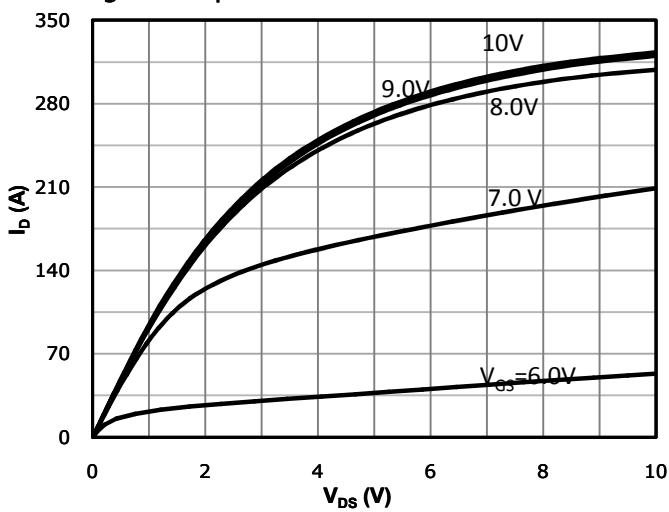
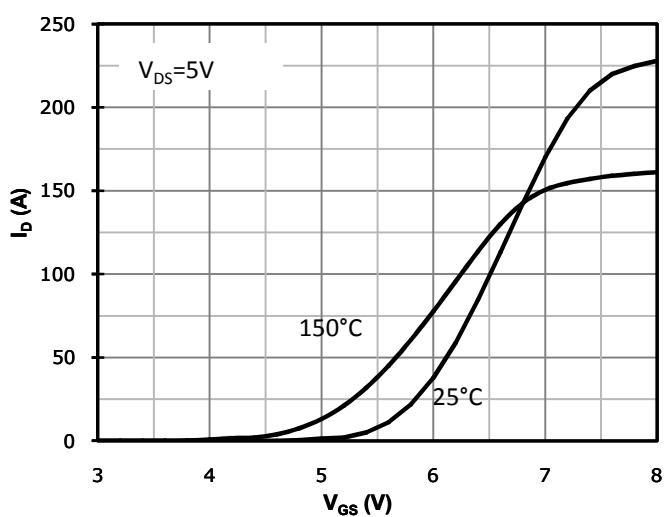
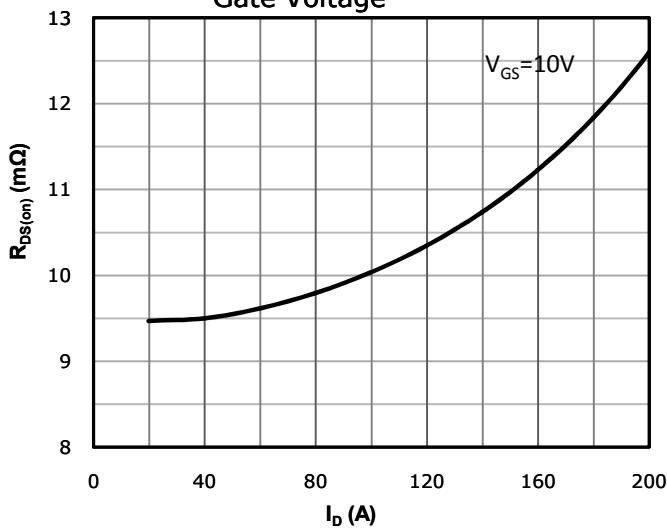
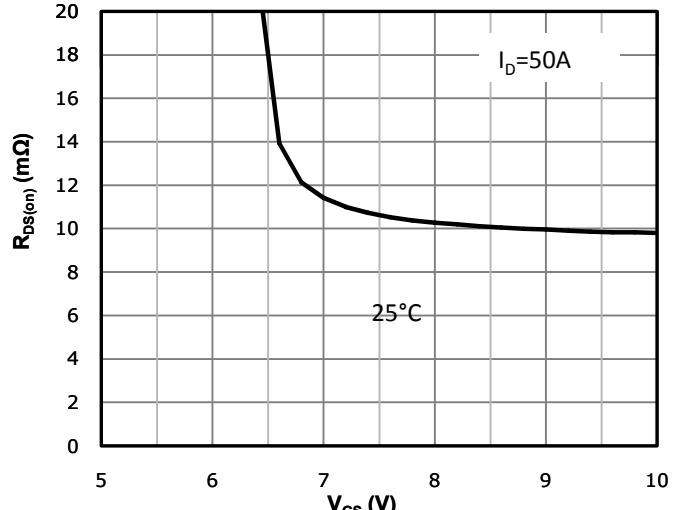
Fig 1: Output Characteristics

Fig 2: Transfer Characteristics

Fig 3: R_{ds(on)} vs Drain Current and Gate Voltage

Fig 4: R_{ds(on)} vs Gate Voltage


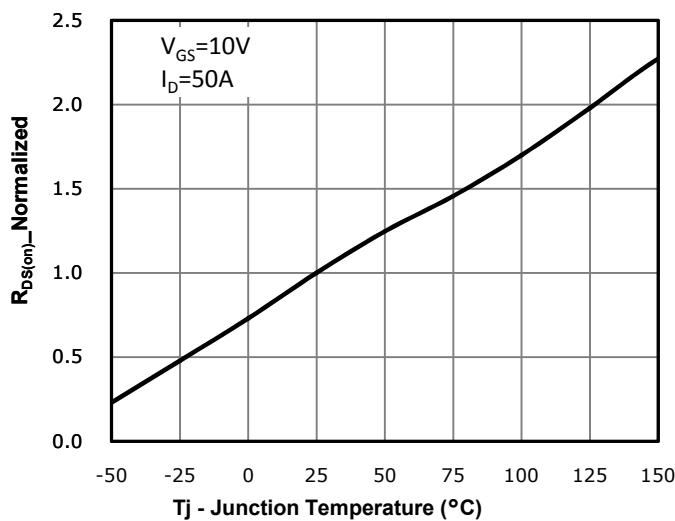
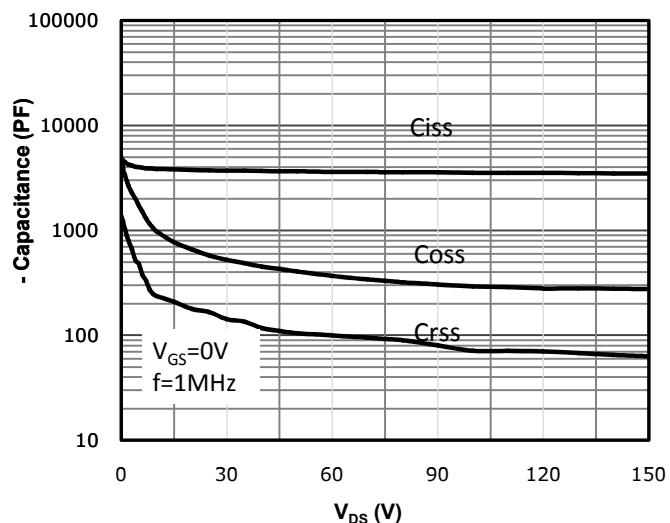
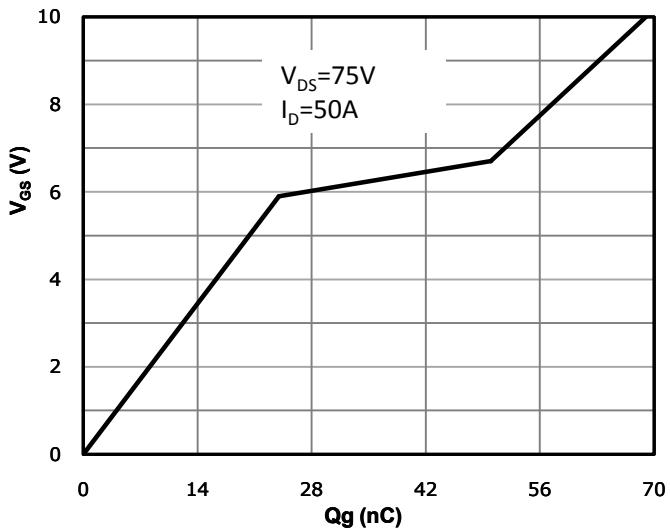
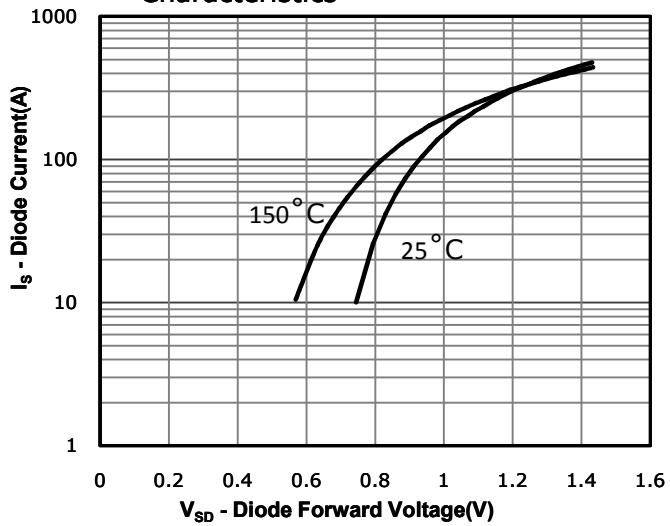
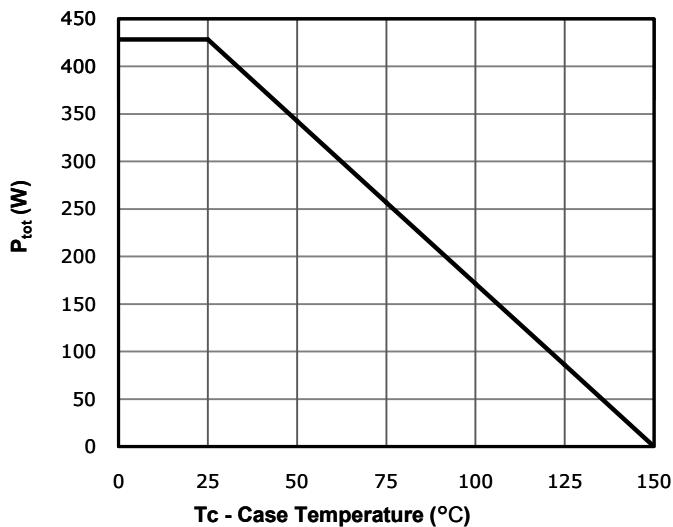
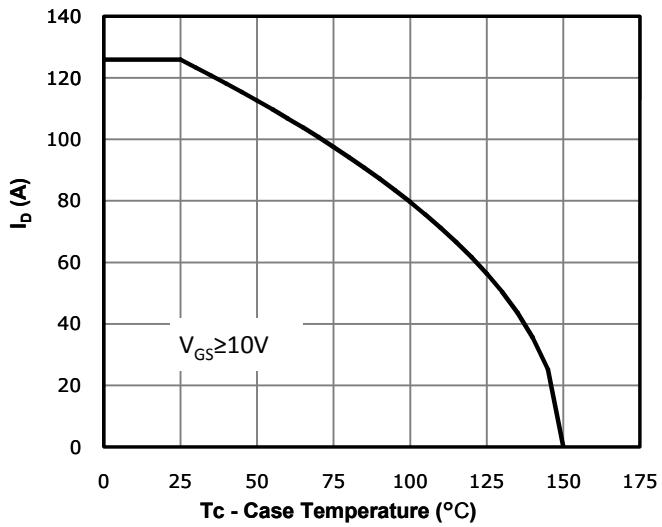
Fig 5: R_{ds(on)} vs. Temperature

Fig 6: Capacitance Characteristics

Fig 7: Gate Charge Characteristics

Fig 8: Body-diode Forward Characteristics

Fig 9: Power Dissipation

Fig 10: Drain Current Derating


Fig 11: Safe Operating Area

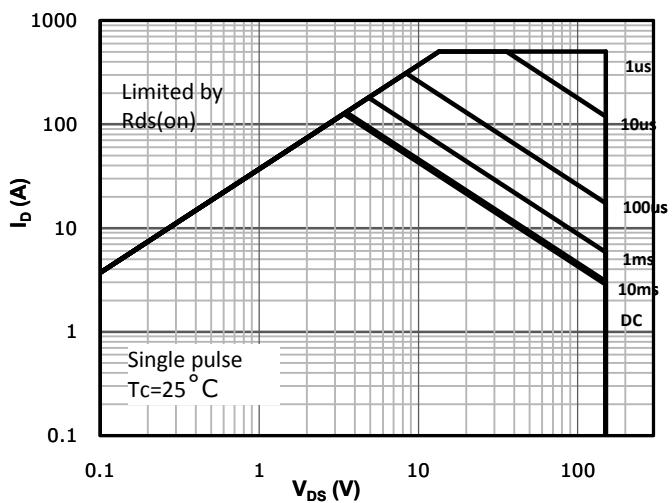
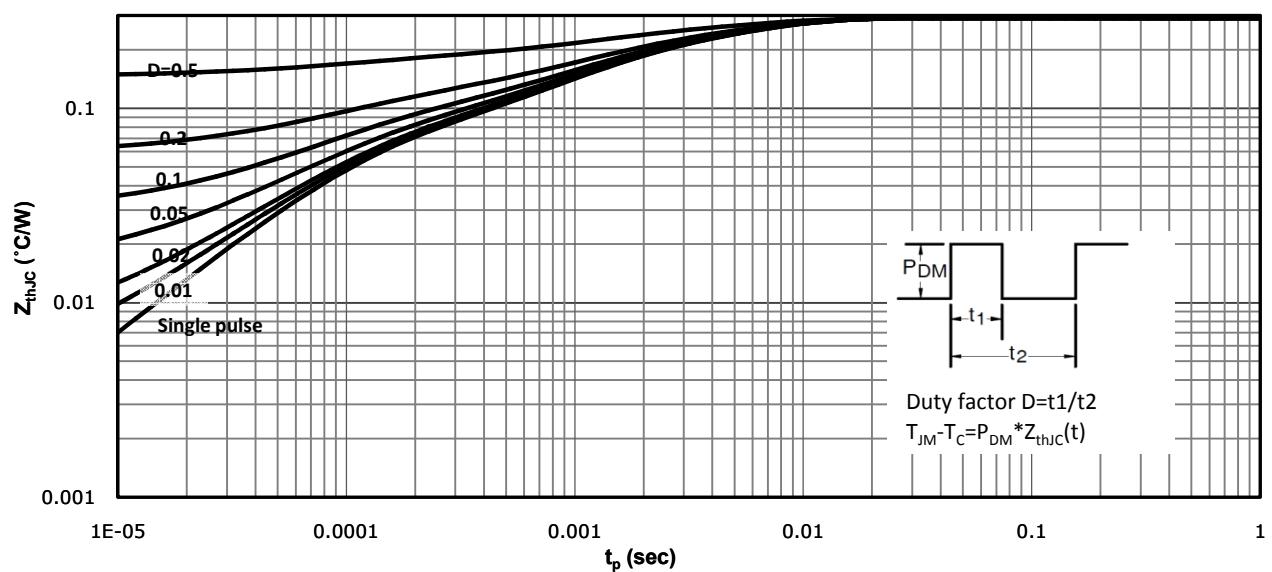
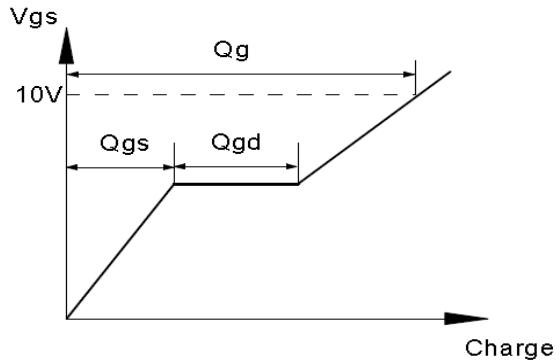
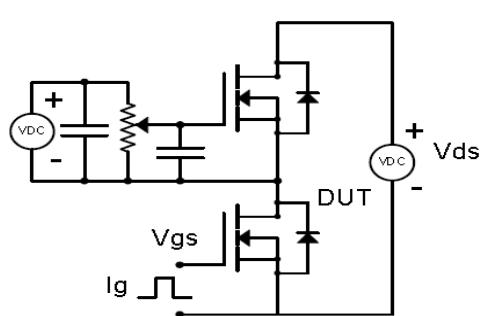


Fig 12: Max. Transient Thermal Impedance

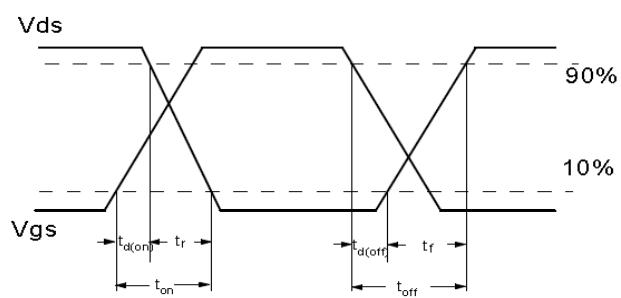
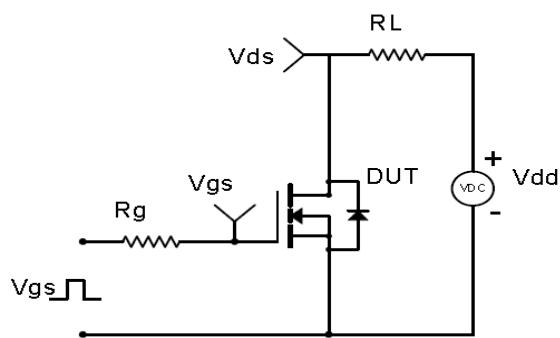


**Test Circuit & Waveform**

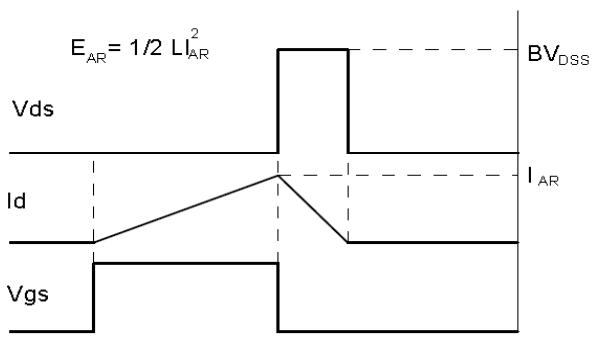
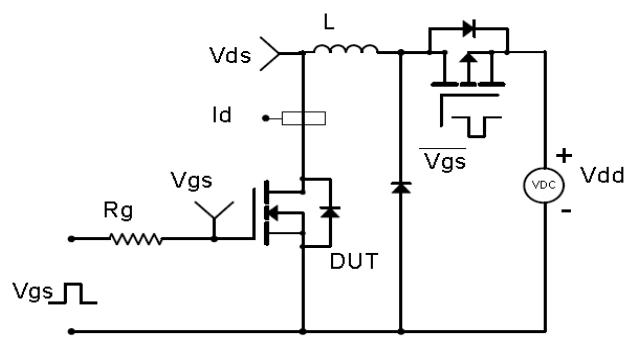
Gate Charge Test Circuit & Waveform



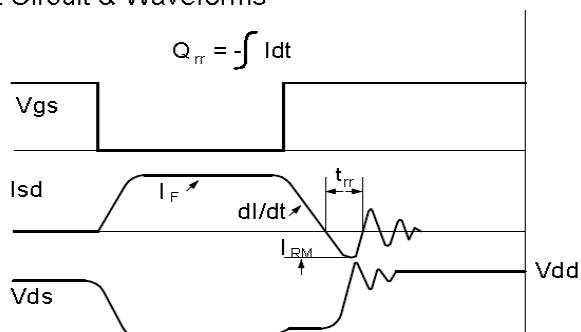
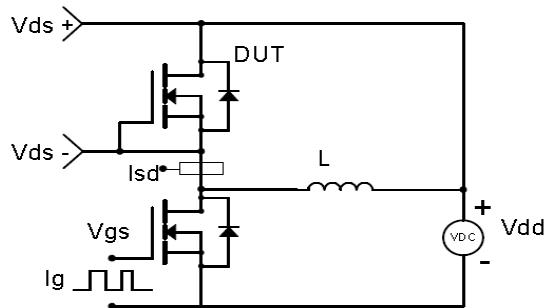
Resistive Switching Test Circuit & Waveforms

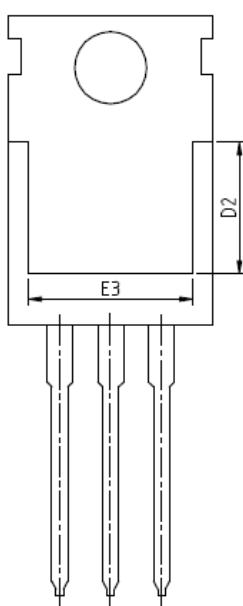
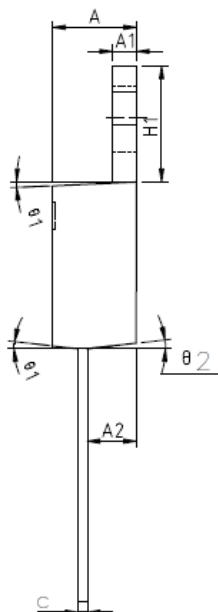
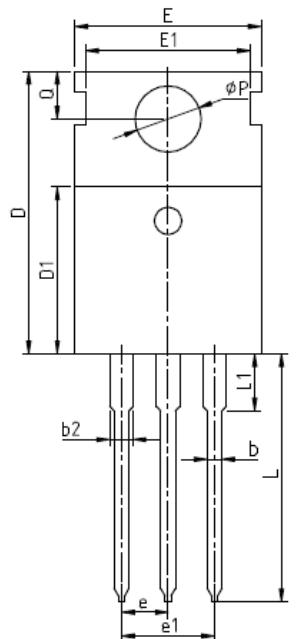


Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Package Outline: TO-220-3L


SYMBOL	MIN	NOM	MAX
A	4.27	4.57	4.87
A1	1.15	1.30	1.45
A2	2.10	2.40	2.70
b	0.70	0.80	1.00
b2	1.17	1.27	1.50
c	0.40	0.50	0.65
D	15.10	15.60	16.10
D1	8.80	9.10	9.40
D2	5.70	6.70	7.00
E	9.70	10.00	10.30
E1	-	8.70	-
E2	9.65	10.00	10.35
E3	7.00	8.00	8.40
e		2.54 BSC	
e1		5.08 BSC	
H1	6.00	6.50	6.85
L	12.75	13.50	13.90
L1	-	3.10	3.40
ΦP	3.45	3.60	3.75
Q	2.60	2.80	3.00
θ1	4°	7°	10°
θ2	0°	3°	6°



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